FAIRCHILD SEMICONDUCTOR™

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DM7474
Dual Positive-Edge-Triggered D-Type Flip-Flops with Preset, Clear and Complementary Outputs

General Description

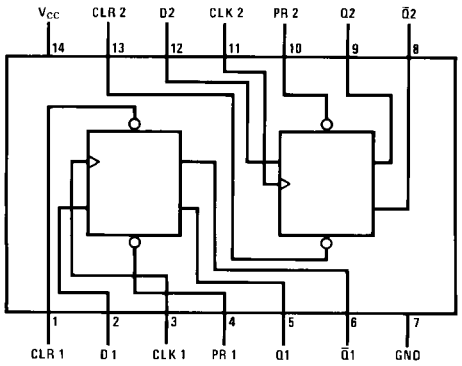
This device contains two independent positive-edge-triggered D-type flip-flops with complementary outputs. The information on the D input is accepted by the flip-flops on the positive going edge of the clock pulse. The triggering occurs at a voltage level and is not directly related to the transition time of the rising edge of the clock. The data on the D input may be changed while the clock is LOW or HIGH without affecting the outputs as long as the data setup and hold times are not violated. A LOW logic level on the preset or clear inputs will set or reset the outputs regardless of the logic levels of the other inputs.

Ordering Code:

Order Number	Package Number	Package Description
DM7474M	M14A	14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
DM7474N	N14A	14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide

Devices also available in Tape and Reel. Specify by appending the suffix letter "X" to the ordering code.

Connection Diagram



Function Table

Inputs				Outputs	
PR	CLR	CLK	D	Q	$\overline{Q}$
L	H	X	X	H	L
H	L	X	X	L	H
L	L	X	X	H (Note 1)	H (Note 1)
H	H	↑	H	H	L
H	H	↑	L	L	H
H	H	L	X	Q_0	$\overline{Q}_0$

H = HIGH Logic Level
X = Either LOW or HIGH Logic Level
L = LOW Logic Level
↑ = Positive-going transition of the clock.
Q_0 = The output logic level of Q before the indicated input conditions were established.

Note 1: This configuration is nonstable; that is, it will not persist when either the preset and/or clear inputs return to their inactive (HIGH) level.

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Absolute Maximum Ratings(Note 2)

Supply Voltage	7V
Input Voltage	5.5V
Operating Free Air Temperature Range	0°C to +70°C
Storage Temperature Range	−65°C to +150°C

Note 2: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions for actual device operation.

Recommended Operating Conditions

Symbol	Parameter		Min	Nom	Max	Units
V_{CC}	Supply Voltage		4.75	5	5.25	V
V_{IH}	HIGH Level Input Voltage		2			V
V_{IL}	LOW Level Input Voltage				0.8	V
I_{OH}	HIGH Level Output Current				−0.4	mA
I_{OL}	LOW Level Output Current				16	mA
f_{CLK}	Clock Frequency (Note 4)		0		15	MHz
t_W	Pulse Width (Note 4)	Clock HIGH	30			ns
		Clock LOW	37			
		Clear LOW	30			
		Preset LOW	30			
t_{SU}	Input Setup Time (Note 3)(Note 4)		20↑			ns
t_H	Input Hold Time (Note 3)(Note 4)		5↑			ns
T_A	Free Air Operating Temperature		0		70	°C

Note 3: The symbol (↑) indicates the rising edge of the clock pulse is used for reference.

Note 4: $T_A = 25°C$ and $V_{CC} = 5V$.

Electrical Characteristics

over recommended operating free air temperature range (unless otherwise noted)

Symbol	Parameter	Conditions		Min	Typ (Note 5)	Max	Units
V_I	Input Clamp Voltage	V_{CC} = Min, I_I = −12 mA				−1.5	V
V_{OH}	HIGH Level Output Voltage	V_{CC} = Min, I_{OH} = Max V_{IL} = Max, V_{IH} = Min		2.4	3.4		V
V_{OL}	LOW Level Output Voltage	V_{CC} = Min, I_{OL} = Max V_{IH} = Min, V_{IL} = Max			0.2	0.4	V
I_I	Input Current @ Max Input Voltage	V_{CC} = Max, V_I = 5.5V				1	mA
I_{IH}	HIGH Level Input Current	V_{CC} = Max V_I = 2.4V	D			40	µA
			Clock			80	
			Clear			120	
			Preset			40	
I_{IL}	LOW Level Input Current	V_{CC} = Max V_I = 0.4V (Note 8)	D			−1.6	mA
			Clock			−3.2	
			Clear			−3.2	
			Preset			−1.6	
I_{OS}	Short Circuit Output Current	V_{CC} = Max (Note 6)		−18		−55	mA
I_{CC}	Supply Current	V_{CC} = Max (Note 7)			17	30	mA

Note 5: All typicals are at $V_{CC} = 5V$, $T_A = 25°C$.

Note 6: Not more than one output should be shorted at a time.

Note 7: With all outputs open, I_{CC} is measured with the Q and $\overline{Q}$ outputs HIGH in turn. At the time of measurement the clock is grounded.

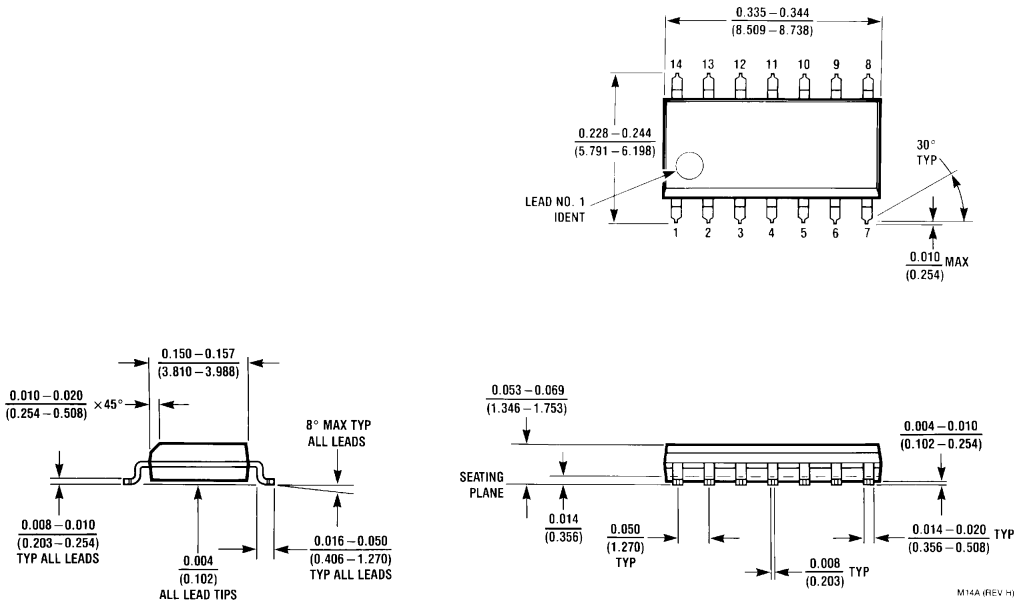
Note 8: Clear is tested with preset HIGH and preset is tested with clear HIGH.

Switching Characteristics

at V_{CC} = 5V and T_A = 25°C

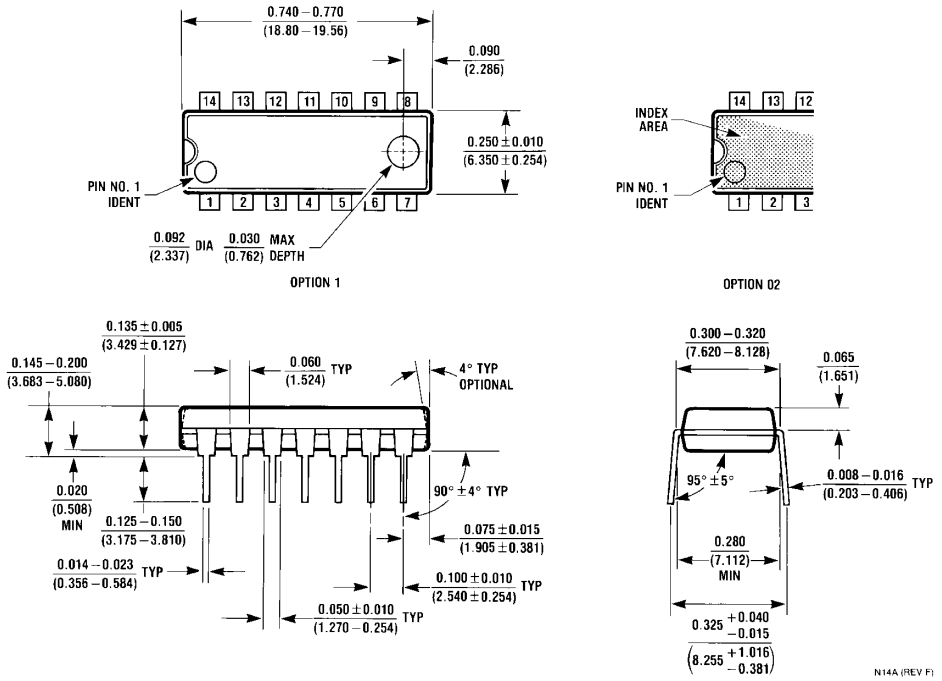
Symbol	Parameter	From (Input) To (Output)	R_L = 400Ω, C_L = 15 pF		Units
			Min	Max	
f_{MAX}	Maximum Clock Frequency		15		MHz
t_{PHL}	Propagation Delay Time HIGH-to-LOW Level Output	Preset to $\overline{Q}$		40	ns
t_{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	Preset to Q		25	ns
t_{PHL}	Propagation Delay Time HIGH-to-LOW Level Output	Clear to Q		40	ns
t_{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	Clear to $\overline{Q}$		25	ns
t_{PHL}	Propagation Delay Time HIGH-to-LOW Level Output	Clock to Q or $\overline{Q}$		40	ns
t_{PLH}	Propagation Delay Time LOW-to-HIGH Level Output	Clock to Q or $\overline{Q}$		25	ns

Physical Dimensions inches (millimeters) unless otherwise noted



14-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150 Narrow
Package Number M14A

Physical Dimensions inches (millimeters) unless otherwise noted (Continued)



14-Lead Plastic Dual-In-Line Package (PDIP), JEDEC MS-001, 0.300 Wide
Package Number N14A

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